



PATENT NUMBER and ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM	FILING DATE)	SUBCLASS	1	EXAMINER				
10083611	02/27/2002	257	316	2812	BOSTL				
**APPLICANTS: Hisamune Yoshiaki; Nakata Hidetoshi; **CONTINUING DATA VERIFIED: THIS APPLICATION IS A DIV OF 09/489,332 01/21/2000 PAT 6,373,096									
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** FOREIGN APPLICATIONS VERIFIED: JAPAN 11-014707 01/22/1999									
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Foreign priority clai 35 USC 119 condit Verified and Ackno	med ions met wledged Examiners's in	□ yes itials	no no		ATTORNEY DOCKET NO 8020-1002-1				
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NOTICE OF ALLOWANCE MAILED			CLAIMS ALLOWED			D	
		Assistant Examiner	Total Claims		Print Claim for O.G		
ISSUE FEE			DRAWING				
Amount Due	Date Paid		Sheets Drwg.	Figs.Drv	Mg.	Print Fig.	
l 		Primary Examiner					
TERMINAL DISCLAMER		PREPARED FOR ISSUE	Application Examiner				
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